

# SK75GAL12T4



**SEMITOP<sup>®</sup> 2**

## IGBT Module

SK75GAL12T4

SK75GAR12T4

Target Data

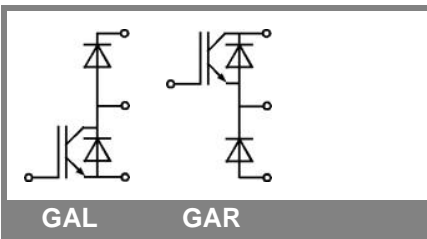
### Features

- One screw mounting module
- Trench4 IGBT technology
- CAL4 technology FWD

### Typical Applications

### Remarks

- $V_{CE,sat}$ ,  $V_F$  = chip level value



GAL

GAR

Absolute Maximum Ratings		$T_s = 25\text{ °C}$ , unless otherwise specified		
Symbol	Conditions	Values		Units
<b>IGBT</b>				
$V_{CES}$	$T_j = 25\text{ °C}$	1200		V
$I_C$	$T_j = 175\text{ °C}$	$T_s = 25\text{ °C}$	80	A
		$T_s = 70\text{ °C}$	65	A
$I_{CRM}$	$I_{CRM} = 3 \times I_{Cnom}$	225		A
$V_{GES}$		± 20		V
$t_{psc}$	$V_{CC} = 800\text{ V}$ ; $V_{GE} \leq 15\text{ V}$ ; $T_j = 150\text{ °C}$ $V_{CES} < 1200\text{ V}$	10		µs
<b>Inverse Diode</b>				
$I_F$	$T_j = 175\text{ °C}$	$T_s = 25\text{ °C}$	20	A
		$T_s = 70\text{ °C}$	16	A
$I_{FRM}$	$I_{FRM} = 3 \times I_{Fnom}$	45		A
$I_{FSM}$	$t_p = 10\text{ ms}$ ; half sine wave $T_j = 150\text{ °C}$	90		A
<b>Freewheeling Diode</b>				
$I_F$	$T_j = 175\text{ °C}$	$T_s = 25\text{ °C}$	70	A
		$T_s = 70\text{ °C}$	55	A
$I_{FRM}$	$I_{FRM} = 3 \times I_{Fnom}$	225		A
$I_{FSM}$	$t_p = 10\text{ ms}$ ; half sine wave $T_j = 150\text{ °C}$	425		A
<b>Module</b>				
$I_{t(RMS)}$				A
$T_{vj}$		-40 ... +175		°C
$T_{stg}$		-40 ... +125		°C
$V_{isol}$	AC, 1 min.	2500		V

Characteristics		$T_s = 25\text{ °C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 3\text{ mA}$	5	5,8	6,5	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ , $V_{CE} = V_{CES}$	$T_j = 25\text{ °C}$	0,01		mA
		$T_j = 150\text{ °C}$			mA
$I_{GES}$	$V_{CE} = 0\text{ V}$ , $V_{GE} = 20\text{ V}$	$T_j = 25\text{ °C}$	600		nA
		$T_j = 150\text{ °C}$			nA
$V_{CE0}$		$T_j = 25\text{ °C}$	1,1	1,3	V
		$T_j = 150\text{ °C}$	1	1,2	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$	10		mΩ
		$T_j = 150\text{ °C}$	16		mΩ
$V_{CE(sat)}$	$I_{Cnom} = 75\text{ A}$ , $V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}_{chiplev.}$	1,85	2,05	V
		$T_j = 150\text{ °C}_{chiplev.}$	2,25	2,45	V
$C_{ies}$	$V_{CE} = 25$ , $V_{GE} = 0\text{ V}$	4,4		nF	
$C_{oes}$		0,29		nF	
$C_{res}$		0,235		nF	
$Q_G$	$V_{GE} = -7\text{ V} \dots +15\text{ V}$	570		nC	
$R_{Gint}$	$T_j = 25\text{ °C}$	10		Ω	
$t_{d(on)}$	$R_{Gon} = 24\text{ Ω}$ $di/dt = 1360\text{ A/μs}$	63		ns	
$t_r$		65		ns	
$E_{on}$		$V_{CC} = 600\text{ V}$ $I_C = 75\text{ A}$	13,6		mJ
$t_{d(off)}$	$R_{Goff} = 24\text{ Ω}$	521		ns	
$t_f$		$T_j = 150\text{ °C}$ $V_{GE} = -7/+15\text{ V}$	80		ns
$E_{off}$		8,2		mJ	
$R_{th(j-s)}$	per IGBT	0,74		K/W	

# SK75GAL12T4



**SEMISTOP<sup>®</sup> 2**

## IGBT Module

**SK75GAL12T4**

**SK75GAR12T4**

Target Data

### Features

- One screw mounting module
- Trench4 IGBT technology
- CAL4 technology FWD

### Typical Applications

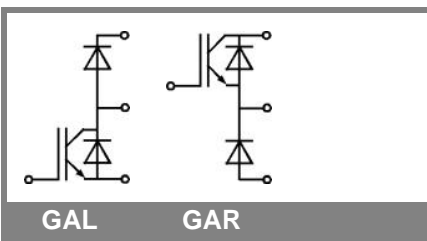
### Remarks

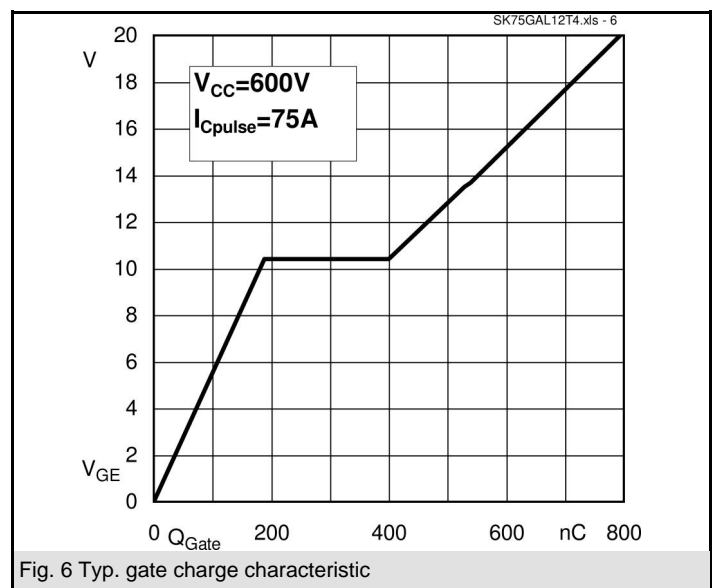
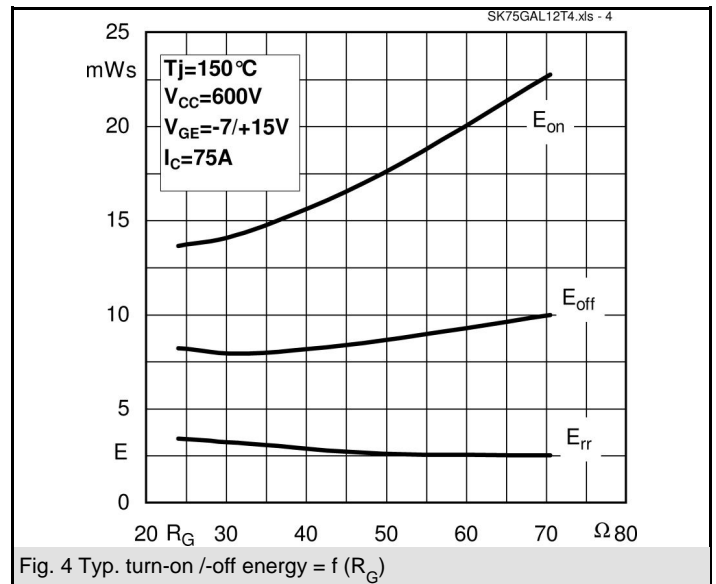
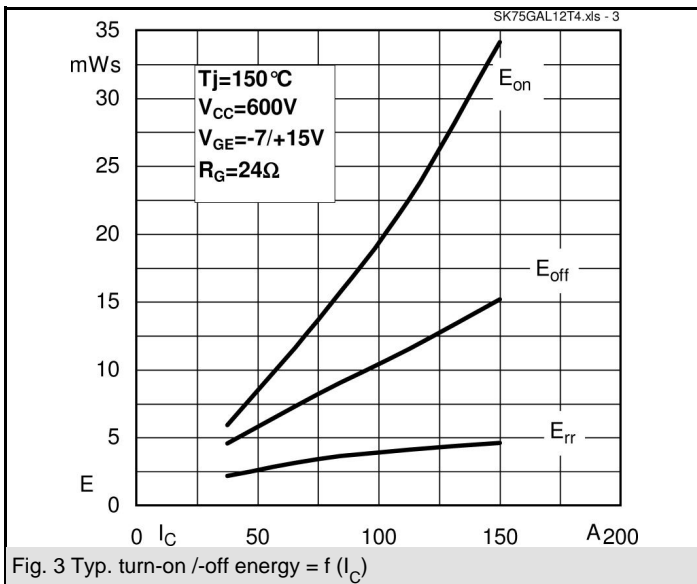
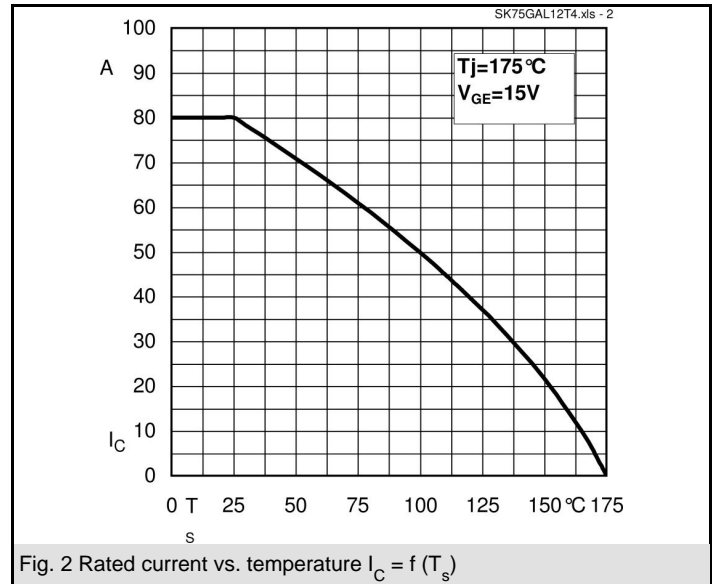
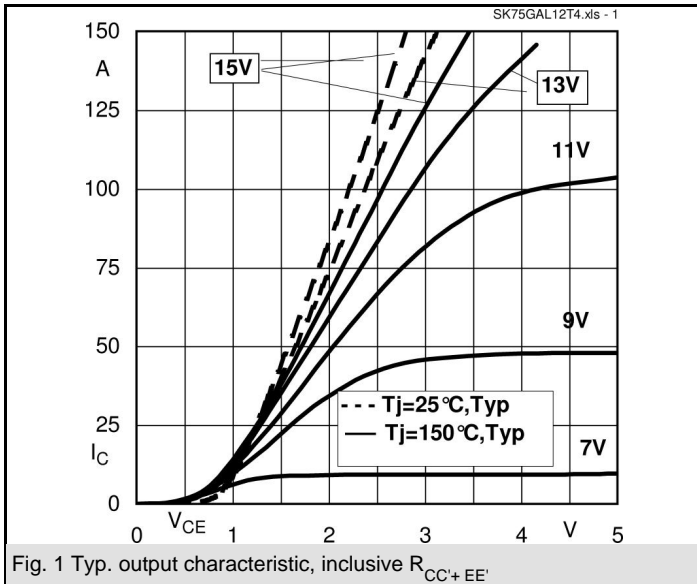
- $V_{CE,sat}$ ,  $V_F$  = chip level value

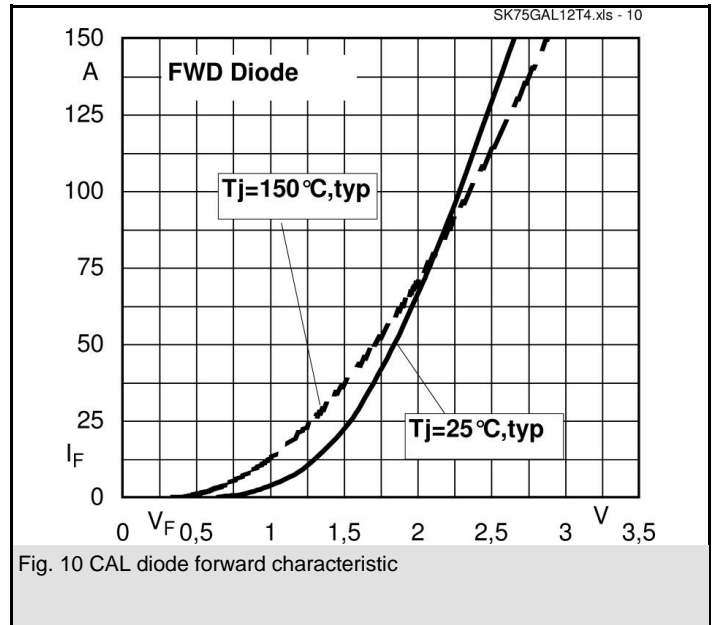
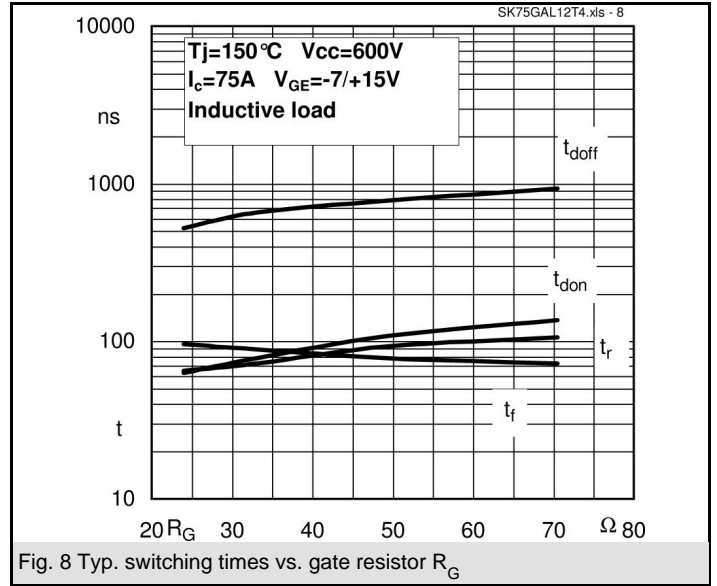
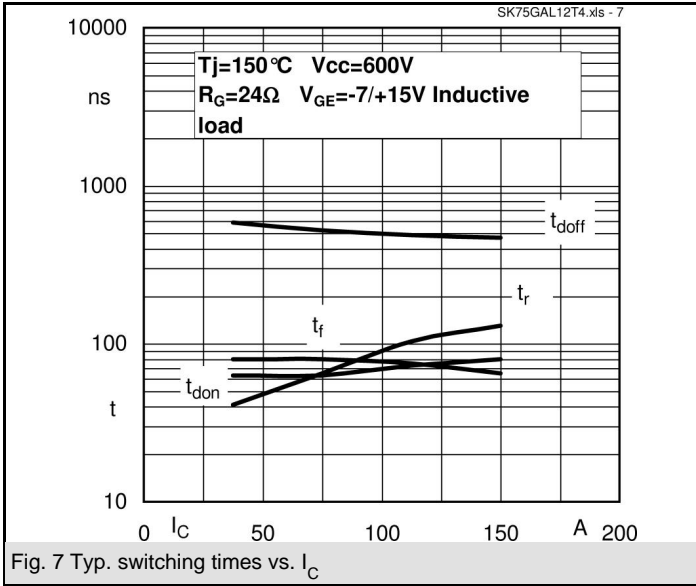
Characteristics			min.	typ.	max.	Units
Symbol	Conditions					
<b>Inverse Diode</b>						
$V_F = V_{EC}$	$I_{Fnom} = 15 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$		2,38	2,71	V
		$T_j = 150 \text{ }^\circ\text{C}_{chiplev.}$		2,44	2,77	V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$		1,3	1,5	V
		$T_j = 150 \text{ }^\circ\text{C}$		0,9	1,1	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$		72	80,7	m $\Omega$
		$T_j = 150 \text{ }^\circ\text{C}$		102,8	111,6	m $\Omega$
$I_{RRM}$	$I_F = \text{A}$	$T_j = 150 \text{ }^\circ\text{C}$				A
$Q_{rr}$						$\mu\text{C}$
$E_{rr}$	$V_{CC} = 600\text{V}$					mJ
$R_{th(j-s)D}$	per diode			2,34		K/W
<b>Freewheeling Diode</b>						
$V_F = V_{EC}$	$I_{Fnom} = 75 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{chiplev.}$		2,1	2,5	V
		$T_j = 150 \text{ }^\circ\text{C}_{chiplev.}$		2,4	2,5	V
$V_{F0}$		$T_j = 25 \text{ }^\circ\text{C}$		1,3	1,5	V
		$T_j = 150 \text{ }^\circ\text{C}$		0,9	1,1	V
$r_F$		$T_j = 25 \text{ }^\circ\text{C}$		12	13,3	V
		$T_j = 150 \text{ }^\circ\text{C}$		16	17,3	V
$I_{RRM}$	$I_F = 75 \text{ A}$	$T_j = 150 \text{ }^\circ\text{C}$		41		A
$Q_{rr}$	$di/dt = 1360 \text{ A}/\mu\text{s}$			10,6		$\mu\text{C}$
$E_{rr}$	$V_{CC} = 600\text{V}$			3,39		mJ
$R_{th(j-s)FD}$	per diode			0,97		K/W
$M_s$	to heat sink				2,5	Nm
w				30		g
<b>Temperature sensor</b>						
$R_{100}$	$T_s = 100^\circ\text{C}$ ( $R_{25} = 5\text{k}\Omega$ )			493 $\pm$ 5%		$\Omega$

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

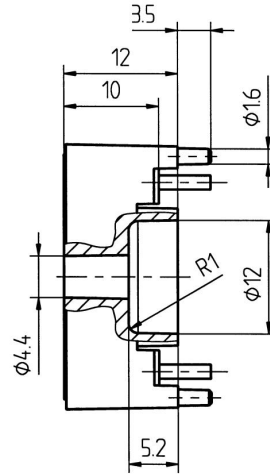
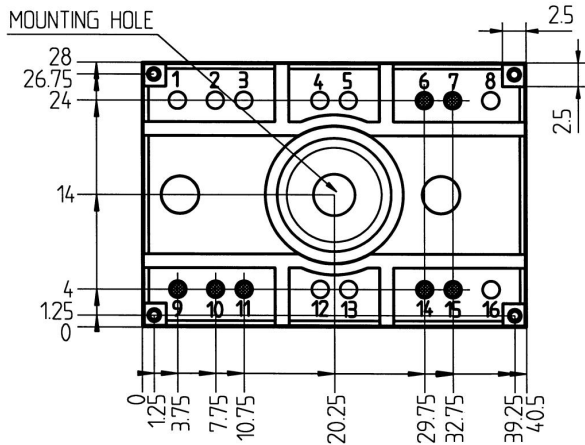
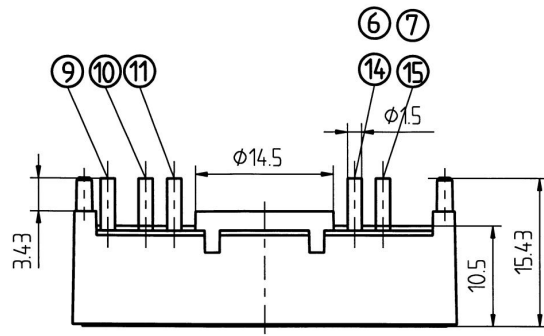
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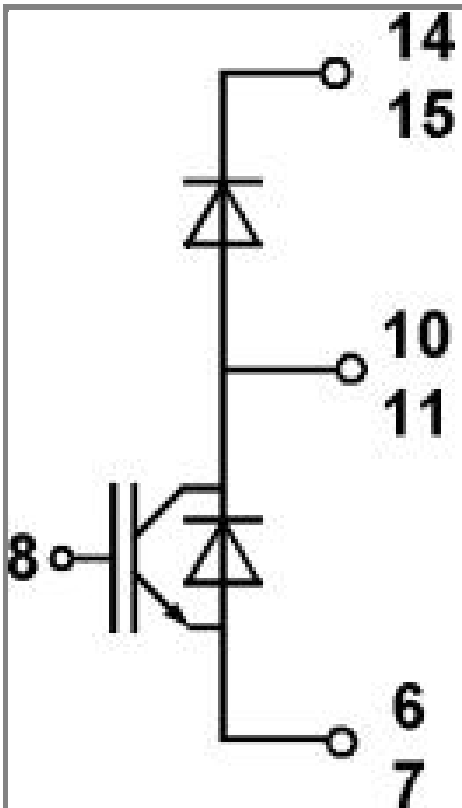




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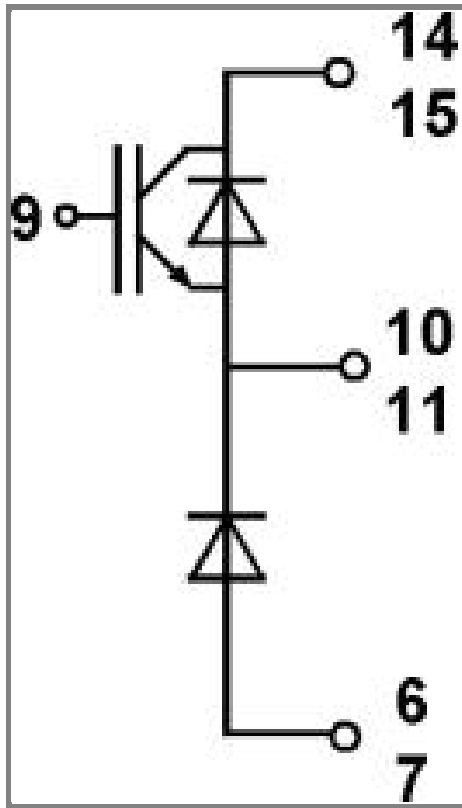


Case T18 (Suggested hole diameter for the solder pins and mounting plastic pins: 2mm)



Case T18

GAL



Case T18

GAR